 rcn No	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,744	HICKS ET AL.	
Examiner	Art Unit	
Chuck Huynh	2617	

SEARCHED			
Class	Subclass	Date	Examiner
Updated	Search	7/8/2007	at at
455	466	7/4/2007	At
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC		<b>(</b> )
	DATE	EXMR
Class/Subclass	7/8/2007	At
Combined Text search	7/8/2007	ar
Reviewed prior arts	7/8/2007	4
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